Thursday Afternoon, October 25, 2018

Nanometer-scale Science and Technology Division Room 102B - Session NS+2D+AS+MN+PC-ThA

SPM – Probing Electronic and Transport Properties

Moderators: Ondrej Dyckoe, Oak Ridge National Laboratory, Sergei Kalinin, Oak Ridge National Laboratory, Indira Seshadri, IBM Research Division, Albany, NY

2:20pm NS+2D+AS+MN+PC-ThA1 Imaging Currents in Two-dimensional Quantum Materials, *Katja Nowack*, Cornell University INVITED

Magnetic imaging is uniquely suited to the non-invasive imaging of current densities, particularly in two-dimensional devices. In this talk, I will showcase this approach by discussing measurements on HgTe quantum well devices in the quantum spin Hall (QSH) regime. In a nutshell, we scan a superconducting quantum interference device (SQUID) to obtain maps of the magnetic field produced by the current flowing in a device. From the magnetic image we reconstruct a two-dimensional current distribution with a spatial resolution on the micron scale. This allows us to directly visualize that most of the current is carried by the edges of the quantum well devices when tuned into their insulating gaps - a key feature of the QSH state. I will both discuss routes towards improving the spatial resolution of our measurements to sub-micron length scales through a combination of improved image reconstruction and smaller sensor sizes.

3:00pm NS+2D+AS+MN+PC-ThA3 Side-gate Construct for Probing Active Energy Levels in Electron Transport through a Solid-state Surface-bound Protein Monolayer, Sidney Cohen, B. Kayser, C. Gua, M. Sheves, I. Pecht, D. Cahen, Weizmann Institute of Science, Israel

Electron transport studies provide an excellent platform to deduce electronic structure in molecular electronics studies, enabling control and understanding of the pathways and mechanisms involved. Due to their complexity, proteins are used only infrequently in this context, despite convenient properties such as selective binding, self-assembly, light sensitivity, and the possibility to (bio) chemically tailor properties . Here, we study electron transport in monolayer films of Azurin, using a 3electrode configuration with a novel side-gate. The source and drain are gold substrate and conductive atomic force microscope (C-AFM) probe, respectively. The measuring devices were prepared in a two-step electron beam lithography process, whereby interdigitated drain and gate electrodes with separation of 80 nanometers are patterned from macroscopic electrodes, the latter formed optically on a silicon oxide substrate. The gold electrodes are patterned with the gate elevated by 20 nm for improved coupling with the drain. After deposition of the Azurin monolayer on this structure, the carrier chip was wire-bonded for insertion into the AFM. Azurin was incorporated in the device both as coppercontaining holo-Azurin, and as apo-Azurin with the Cu ion removed. Stability of source-drain vs. V_{source-drain} curves, as well as gate-drain leakage were monitored for validity. Isource-drain vs. Vsource-drain curves were acquired at different gate voltages, and I_{source-drain} at 0 V_{source-drain} was measured while sweeping V_{gate} in both polarities. Asymmetry of current onset for opposing gate biases points to a low-lying LUMO transport level for holo-Azurin. For apo-Azurin this level is shifted to higher values and hence inaccessible. Semi-quantitative location of the tail of this LUMO, as well as value of gate coupling were estimated by changing the work function of the drain electrode, i.e. C-AFM probe, from Pt (ϕ =-5.3 eV) to Au (ϕ = -4.9 eV). The observations can be rationalized by considering previous electrochemical and theoretical studies.

3:20pm NS+2D+AS+MN+PC-ThA4 Adding Electrons One at a Time to Electrostatically Confined Graphene Quantum Dots, Daniel Walkup, C. Gutierrez, F. Ghahari, National Institute of Standards and Technology (NIST)/ University of Maryland, College Park; C. Lewandowski, MIT; J. Rodriguez-Nieva, Harvard University; T. Taniguchi, K. Watanabe, National Institute for Materials Science (NIMS), Japan; L. Levitov, MIT; N.B. Zhitenev, J.A. Stroscio, National Institute of Standards and Technology (NIST)

The Coulomb blockade of adding charges to isolated metallic systems is one of the most characteristic phenomena of quantum dots (QDs). Here, we created circular graphene QDs in a backgated graphene-hexagonal boron nitride (hBN) device by locally ionizing defects in the hBN layer, using the electric field from the tip of a scanning tunneling microscope (STM). Scanning tunneling spectroscopy (STS) enables us to image the local density of states outside and within these circular graphene resonators. At weak

magnetic fields, confinement of graphene electrons is poor and Coulomb blockade is not observed. At higher fields, however, the graphene electrons form quantized Landau levels (LLs) separated by energy gaps. In the area of the QD, the LLs are bent by the electrostatic potential creating metallic (compressible) rings where a LL crosses the Fermi energy, separated by circular insulating barriers (incompressible strips), which isolate the dot from the graphene and enable the onset of Coulomb blockade. Tunneling dI/dV spectra inside the QD reveal a series of Coulomb blockade peaks, which shift as a function of back gate voltage. In the plane defined by gate voltage and sample bias, these peaks form Coulomb lines, whose slope is governed by the relative capacitances between the dot, tip, gate, and sample bias electrodes, and whose relative offsets reveal the addition spectrum of the quantum dot. A characteristic feature of the Coulomb blockade in these systems is the presence of different families of charging lines, one for each LL, which intersect each other and experience avoided crossings. The avoidance pattern of these anticrossings is novel: at the strongest fields, it somewhat resembles the predictions of simple models of electrostatically-coupled QDs, but at weaker fields it diverges very strikingly, and new modeling is needed to reproduce it. This avoidance pattern reflects the interaction of electrons in different LLs, occupying different parts of the QD, and is tunable via the magnetic field and gate voltage. By moving the STM tip, we can tune the tip-dot capacitance, and tunnel into different parts of the dot, enabling a full characterization of the anticrossings in these novel electronic nanostructures.

4:00pm NS+2D+AS+MN+PC-ThA6 Bulk and Surface Contribution to the Charge and Spin Transport in Topological Insulators Observed with a Four-Probe Scanning Tunneling Microscope, Wonhee Ko, G.D. Nguyen, Oak Ridge National Laboratory; H. Kim, J.S. Kim, Pohang University of Science and Technology, Republic of Korea; A.-P. Li, Oak Ridge National Laboratory

Topological insulators are fascinating materials for future electronics because of its superior charge and spin transport characteristics stemming from their topological nature. However, topological insulators realized in actual materials have both bulk and surface carriers, where the former significantly hampers the topological transport of the later. In this talk, we utilize four-probe scanning tunneling microscope to investigate bulk and surface contribution to the charge and spin transport in bulk-insulating topological insulator Bi₂Te₂Se. The relative contribution of bulk and surface was varied by changing temperature and transport area, which was measured by variable probe-spacing spectroscopy. The surface dominant regime was already reached at 82 K, where the sample exhibited superior transport properties such as a large surface mobility and high spin polarization. At this regime, the contact to external probes also transforms from Schottky to Ohmic junction. Our result indicates that controlling bulk and surface contribution to the transport is crucial for realizing topological devices

4:20pm NS+2D+AS+MN+PC-ThA7 Modulation of Single-Walled Carbon Nanotube Electronic Structure by External Electronic Perturbations: Scanning Tunneling Spectroscopy and Density Functional Theory, Benjamen Taber¹, G.V. Nazin, University of Oregon

Understanding the local impact of environmental electronic perturbations on the local density of states (LDOS) of single-walled carbon nanotubes (CNTs) is critical for developing CNT-based devices. We present scanning tunneling microscopy and spectroscopy (STM/STS) investigations of CNTs adsorbed on both a metal, Au(111), and a dielectric, monolayer RbI on Au(111), serving as models for stronger and weaker electrostatic interactions, respectively. In both cases, STS revealed modulations in the CNT LDOS corresponding to features in the underlying material. We then corroborate our STM/STS results with density functional theory calculations of the electronic structure of semiconducting CNTs in the presence and absence of an external dipole (a pair of opposite charges). DFT-calculated CNT LDOS quantitatively matched STM/STS results, providing key insight in to the local impact external charges have on CNT electronic structure.

4:40pm NS+2D+AS+MN+PC-ThA8 Single Charge and Exciton Dynamics probed on the Molecular Scale, Anna Roslawska, P. Merino, C. Grosse, C.C. Leon, O. Gunnarsson, M. Etzkorn, K. Kuhnke, K. Kern, Max Planck Institute for Solid State Research, Germany

The performance of organic optoelectronic devices depends on the dynamics of charges and excitons (electron-hole pairs). The relevant processes have been mostly studied by time-resolved techniques with a spatial resolution limited by optical diffraction. In order to overcome this limit, a nanoscale scanning probe approach that enables addressing

¹ NSTD Postdoc Finalist

Thursday Afternoon, October 25, 2018

individual light emitters is preferred. Here we introduce time-resolved scanning tunneling microscopy-induced luminescence (TR-STML) and use it to explore locally the single charge and single exciton regime. The excitonic light originates from structural defects in C60 thin films on Au(111) that act as charge and exciton traps. Such a defect is a single photon emitter, whose spectrum has a sharp electron-hole recombination feature [1,2]. By measuring the time-resolved electroluminescence due to individual injected charges, it is possible to analyze the formation and recombination processes of single excitons and determine their characteristic time constants[3].

- [1] P. Merino, C. Große, A. Rosławska, K. Kuhnke, K. Kern, , Nat. Commun., 6, 8461, 2015.
- [2] C. Große, P. Merino, A. Rosławska, O. Gunnarsson, K. Kuhnke, K. Kern, ACS Nano, 11, 1230-1237, 2017.
 - [3] A. Rosławska, P. Merino, C. Große, C. C. Leon, O. Gunnarsson, M. Etzkorn, K. Kuhnke, K. Kern, arXiv:1803.10088.

5:00pm NS+2D+AS+MN+PC-ThA9 Microscopic Understanding of the Temperature-dependent Carrier Transport in Ge Nano - Crystal s Films, Dan Shan, Yangzhou Polytechnic Institute, China; J. Xu, Nanjing Universityy, China

Silica-based semiconductor nano-crystals have attracted much interest in recent years due to their possible applications in many kinds of nano-electronic and optoelectronic devices. Compared with Si, Ge has larger electron and hole mobility. Furthermore, Ge has a narrower band-gap and high phonon responsivity in the near-infrared region, so it is suited to many near-infrared applications. In order to further improve the device performance, detailed knowledge of transport mechanisms across these nano-crystals becomes necessary and is considered indispensable.

In this work, hydrogenated amorphous germanium films were prepared by a plasma enhanced chemical vapor deposition technique. Ge nano-crystals (Ge NCs) films were obtained by thermal annealing the as-deposited samples. P-type behavior in Ge NCs films without any external doping is attributed to the holes accumulation caused by acceptor-like surface states. It can be found that the dark conductivity and Hall mobility reach to as high as 25.4 S/cm and 182 cm²/V·s in the Ge NCs film, which are much higher than the previously reported data. Carrier transport mechanisms of Ge NCs films were investigated by temperature-dependent Hall measurement. Three kinds of temperature-dependent conductivity behaviors, which exhibit the linear relationships of the ln σ versus T^{-1/4}, T^{-1/2} and T-1, respectively, were observed in the temperature regions of 10-500 K. It can be confirmed that the thermal activation conduction in the extended states dominated the carrier transport process above 300 K (300-500 K). Below room temperature, the carrier transport process was dominated by the percolation-hopping conduction at 90-230 K and turned to Mott-VRH conduction when the temperature falling below 50 K (10-50

Furthermore, the different scattering mechanisms in carrier transport process were found in different temperature regions, which were evaluated via temperature-dependent Hall mobilities. In the low temperature region (10-50 K), the carrier Hall mobility is almost temperature independence ($\mu^{\sim}T^{0}$), revealing the neutral impurities' scattering mechanism dominated the carrier transport process. When increasing the temperature (50-190 K), the carrier transport properties were controlled by the grain boundary scattering mechanism, where the carrier Hall mobility was increased with temperature and exhibited the thermally activated behavior. However, the relationship of $\mu^{\sim}T^{-0.9}$ was observed above room temperature (300-500 K). It is suggested that the carrier transport is dominated by a superposition of grain boundary scattering and acoustic phonon scattering within the high temperature region.

Author Index

Bold page numbers indicate presenter

-c-

Cahen, D.: NS+2D+AS+MN+PC-ThA3, 1 Cohen, S.R.: NS+2D+AS+MN+PC-ThA3, 1

 $-\,\mathrm{E}\,-$

Etzkorn, M.: NS+2D+AS+MN+PC-ThA8, 1 — G —

Ghahari, F.: NS+2D+AS+MN+PC-ThA4, 1 Grosse, C.: NS+2D+AS+MN+PC-ThA8, 1 Gua, C.: NS+2D+AS+MN+PC-ThA3, 1 Gunnarsson, O.: NS+2D+AS+MN+PC-ThA8, 1 Gutierrez, C.: NS+2D+AS+MN+PC-ThA4, 1 — K —

Kayser, B.: NS+2D+AS+MN+PC-ThA3, 1 Kern, K.: NS+2D+AS+MN+PC-ThA8, 1 Kim, H.: NS+2D+AS+MN+PC-ThA6, 1 Kim, J.S.: NS+2D+AS+MN+PC-ThA6, 1 Ko, W.: NS+2D+AS+MN+PC-ThA6, 1 Kuhnke, K.: NS+2D+AS+MN+PC-ThA8, 1 Leon, C.C.: NS+2D+AS+MN+PC-ThA8, 1 Levitov, L.: NS+2D+AS+MN+PC-ThA4, 1

Levitov, L.: NS+2D+AS+MN+PC-ThA4, 1 Lewandowski, C.: NS+2D+AS+MN+PC-ThA4,

Li, A.-P.: NS+2D+AS+MN+PC-ThA6, 1 - M -

Merino, P.: NS+2D+AS+MN+PC-ThA8, 1 - N -

Nazin, G.V.: NS+2D+AS+MN+PC-ThA7, 1 Nguyen, G.D.: NS+2D+AS+MN+PC-ThA6, 1

Nowack, K.C.: NS+2D+AS+MN+PC-ThA1, 1

— P — Pecht, I.: NS+2D+AS+MN+PC-ThA3, 1

- R - Rodriguez-Nieva, J.: NS+2D+AS+MN+PC-

ThA4, 1

Roslawska, A.: NS+2D+AS+MN+PC-ThA8, 1

-s-

Shan, D.: NS+2D+AS+MN+PC-ThA9, **2** Sheves, M.: NS+2D+AS+MN+PC-ThA3, 1 Stroscio, J.A.: NS+2D+AS+MN+PC-ThA4, 1

-T-

Taber, B.N.: NS+2D+AS+MN+PC-ThA7, **1** Taniguchi, T.: NS+2D+AS+MN+PC-ThA4, 1

-w-

Walkup, D.: NS+2D+AS+MN+PC-ThA4, **1** Watanabe, K.: NS+2D+AS+MN+PC-ThA4, 1

-x-

Xu, J.: NS+2D+AS+MN+PC-ThA9, 2

-z-

Zhitenev, N.B.: NS+2D+AS+MN+PC-ThA4, 1